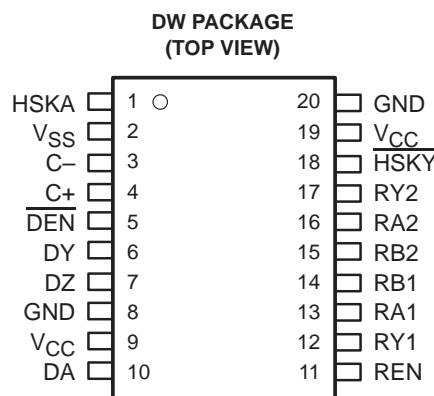


SN75LBC775 SINGLE-CHIP APPLTALK™ AND LOCALTALK™ TRANSCIEVER

SLLS216A – MAY 1995 – REVISED JANUARY 1996

- **Single-Chip Interface Solution for AppleTalk™ and LocalTalk™**
- **Designed to Operate Up To 1 Mbps In AppleTalk and LocalTalk**
- **Switched-Capacitor Voltage Converter Allows for Single 5-V Operation**
- **4-kV ESD Protection on Bus Terminals**
- **Combines Multiple Components into a Single Chip Solution**
- **LinBiCMOS™ Process Technology**



description

The SN75LBC775 is a low-power LinBiCMOS™ device that incorporates the drivers and receivers for an AppleTalk or a LocalTalk interface and a switched-capacitor voltage converter for a single 5-V supply operation. LocalTalk uses a hybrid of RS-422 with the transceiver connected to the network through a small isolation transformer. The AppleTalk mode provides point-to-point communications and uses the same differential driver and receiver as LocalTalk with the addition of a hybrid RS-423, single-ended handshake driver (HSK) and receiver. In the AppleTalk mode, the port connects directly to the receiver with no isolation transformer.

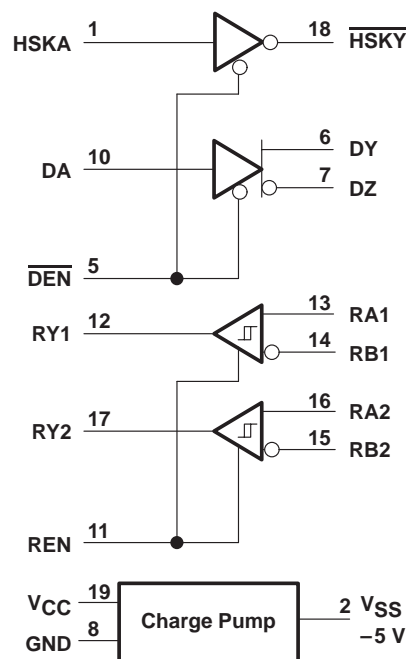
While the device power is turned off ($V_{CC} = 0$) or disabled in the LocalTalk mode, the outputs are in a high-impedance state. When the driver enable (DEN) terminal is high, both the differential and serial driver outputs are in a high-impedance state.

The receiver output can be disabled and becomes a high impedance when the REN terminal is low.

A switched-capacitor voltage converter generates the negative voltage required from a single 5-V supply using two 22- μ F capacitors. One capacitor is between the C+ and C- terminals and the second is between V_{SS} and ground.

The SN75LBC775 is characterized for operating over the temperature range of 0°C to 70°C.

functional diagram



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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SN75LBC775 SINGLE-CHIP APPLE TALK™ AND LOCAL TALK™ TRANSCEIVER

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DRIVER FUNCTION TABLE

INPUT		ENABLE	OUTPUT		
DA	HSKA	$\overline{\text{DEN}}$	A	B	$\overline{\text{HSKY}}$
H	X	L	H	L	X
L	X	L	L	H	X
X	H	L	X	X	L
X	L	L	X	X	H
OPEN	OPEN	L	H	L	L
X	X	H	Z	Z	Z
X	X	OPEN	Z	Z	Z

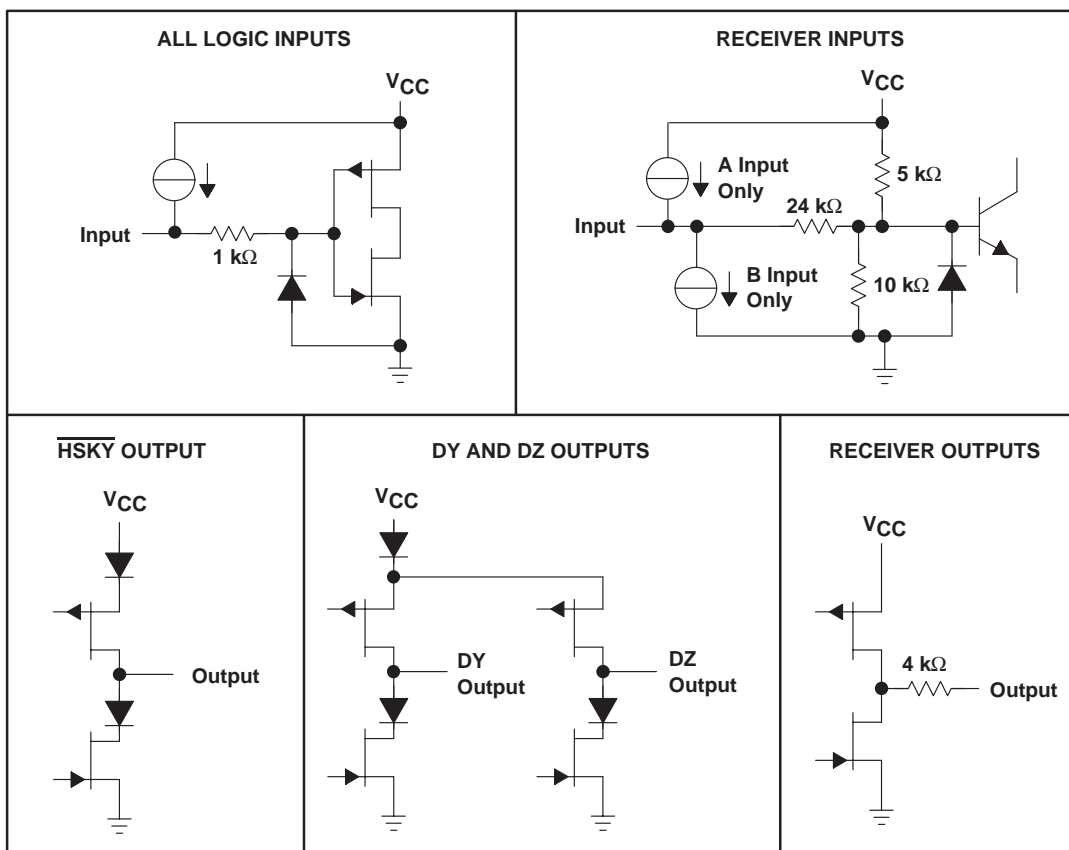
RECEIVER FUNCTION TABLE

INPUT		ENABLE	OUTPUT
RA	RB	REN	RY
H	L	H	H
L	H	H	L
OPEN		H	H
SHORT†		H	?
X		L	Z

† $-0.2 \text{ V} < V_{\text{ID}} < 0.2 \text{ V}$

H = high level, L = low level, X = irrelevant, ? = indeterminate, Z = high impedance (off)

schematics of inputs and outputs



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} (see Note 1)	–0.5 to 7 V
Supply voltage range, V_{SS}	–7 to 0.5 V
Receiver input voltage range, V_I (RA)	–15 V to 15 V
Receiver differential input voltage range, V_{ID}	–12 V to 12 V
Receiver output voltage range, V_O (RY)	–0.5 V to 5.5 V
Driver output voltage range, V_O (Power Off) (DY, DZ, \overline{HSKY})	–15 V to 15 V
(Power On) (DY, DZ, \overline{HSKY})	–11 V to 11 V
Driver input voltage range, V_I (DA, HSKA, \overline{DEN} , REN)	–0.5 V to $V_{CC} + 0.4$ V
Electrostatic discharge (see Note 2) Class 3, A: Bus terminals	4 kV
All other terminals	2 kV
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A	0°C to 70°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to network ground terminal unless otherwise noted.
 2. This maximum rating is tested according to MIL-STD-883C, Method 3015.7.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 85^\circ\text{C}$ POWER RATING
DW	1125 mW	9.0 mW/°C	585 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	4.75	5	5.25	V
High-level input voltage, V_{IH}	DA, HSKA, \overline{DEN} , REN			V
Low-level input voltage, V_{IL}	DA, HSKA, \overline{DEN} , REN			V
Receiver input common-mode voltage range, V_{ICR}^\ddagger	–7		7	V
Differential input voltage, V_{ID}^\ddagger	–12		12	V
Voltage-converter filter capacitance	22			μF
Voltage-converter filter-capacitor equivalent series resistance (ESR)				Ω
Operating free-air temperature, T_A	0		70	°C

† The algebraic convention, in which the less-positive (more negative) limit is designated minimum, is used in this data sheet.



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DRIVER

electrical characteristics over recommend operating characteristics (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT	
V _{OH}	High-level output voltage	R _L = 3 kΩ, See Figure 1	3.7			V	
V _{OL}	Low-level output voltage						
V _{OD}	Magnitude of differential output voltage (V _{DY} – V _{DZ})	See Figure 2	4.0	5.6		V	
Δ V _{OD}	Change in differential voltage magnitude	See Figure 2		10	250	mV	
V _{OC}	Common-mode output voltage‡	See Figure 3	-1		3	V	
ΔV _{OC(SS)}	Change in steady-state common-mode output voltage	See Figure 3			±200	mV	
I _{OZ}	High-impedance output current	V _{CC} = 0, -10 V ≤ V _O ≤ 10 V			±100	μA	
I _{OS}	Short-circuit output current	-5 V ≤ V _O ≤ 5 V			450	mA	
I _{CC}	Supply current	DEN at 0 V, No load REN at 5 V,		5	10	mA	
I _{IH}	High-level input current	V _I = 5 V			200	μA	
I _{IL}	low-level input current	All terminals except REN			-100	-200	μA
		REN	V _I = 0			-300	-455

† All typical values are at V_{CC} = 5 V and T_A = 25°C.

‡ The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet.

switching characteristics over recommend operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PHL}	Propagation delay time, high- to low-level	Single ended	See Figures 1 and 2	155	300	ns
		Differential		115	180	ns
t _{PLH}	Propagation delay time, low- to high-level	Single ended		140	300	ns
		Differential		115	180	ns
t _{PZL}	Propagation delay time, high-impedance to low-level output			100	250	ns
t _{PZH}	Propagation delay time, high-impedance to high-level output			100	250	ns
t _{PLZ}	Propagation delay time, low-level to high-impedance output			100	250	ns
t _{PHZ}	Propagation delay time, high-level to high-impedance output			100	250	ns
t _r	Rise time	Single ended		135	300	ns
		Differential		90	180	ns
t _f	Fall time	Single ended		145	300	ns
		Differential		95	180	ns
t _{sk(p)}	Pulse skew, t _{PLH} - t _{PHL}	Single ended		15	50	ns
		Differential		2	22	ns



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RECEIVER

electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT	
V_{IT+} Positive-going differential input voltage threshold	$I_{OH} = 2 \text{ mA}$, See Figure 4 $I_{OL} = -2 \text{ mA}$			200	mV	
V_{IT-} Negative-going differential input voltage threshold‡				-200	mV	
V_{hys} Input voltage hysteresis ($V_{IT+} - V_{IT-}$)				30	mV	
V_{OH} High-level output voltage			2	4.5		V
V_{OL} Low-level output voltage					0.8	V
I_{OS} Short-circuit output current‡		$V_O = 0$	8	50	85	mA
	$V_O = V_{CC}$	-85	-50	-8	mA	
r_i Input resistance	$V_{CC} = 0$ or 5.25 V , $-12 \text{ V} \leq V_I \leq 12 \text{ V}$	6			k Ω	

† All typical values are at $V_{CC} = 5 \text{ V}$ and $T_A = 25^\circ\text{C}$.

‡ The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet.

switching characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
t_{PHL} Propagation delay time, high- to low-level output	$R_L = 2 \text{ k}\Omega$, See Figure 4 $C_L = 15 \text{ pF}$		25	60	ns
t_{PLH} Propagation delay time, low- to high-level output			22	60	ns
t_r Rise time			8	25	ns
t_f Fall time			7	25	ns
$t_{SK(P)}$ Pulse skew, $ t_{PLH} - t_{PHL} $			3	20	ns
t_{PZL} Receiver output enable time to low-level output	$C_L = 80 \text{ pF}$, See Figure 5		50		ns
t_{PZH} Receiver output enable time to high-level output			50		ns
t_{PLZ} Receiver output disable time to low-level output			50		ns
t_{PHZ} Receiver output disable time to high-level output			50		ns

† All typical values are at $V_{CC} = 5 \text{ V}$ and $T_A = 25^\circ\text{C}$.



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PARAMETER MEASUREMENT INFORMATION

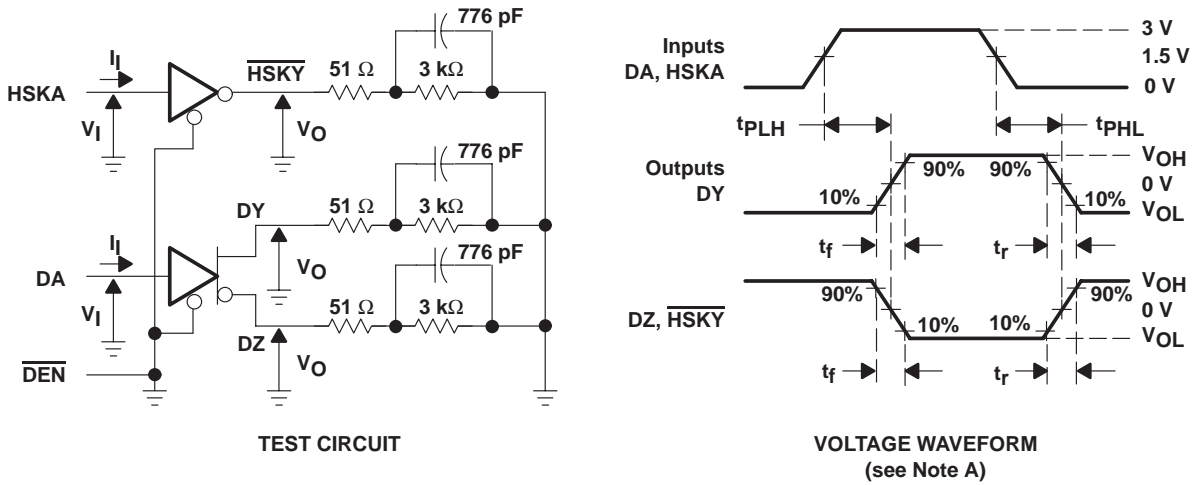
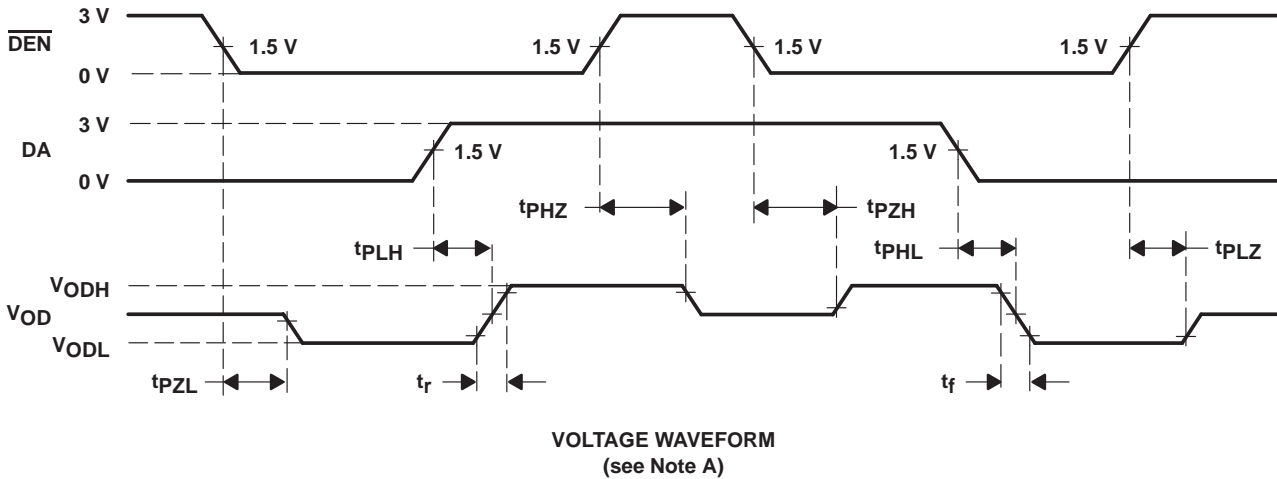
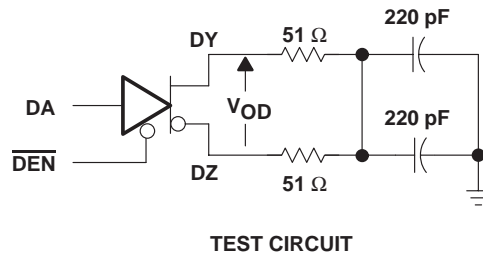


Figure 1. Driver Propagation and Transition Times for AppleTalk



NOTE A: The input waveform $t_r, t_f \leq 10$ ns

Figure 2. Driver Propagation and Transition Times for LocalTalk



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PARAMETER MEASUREMENT INFORMATION

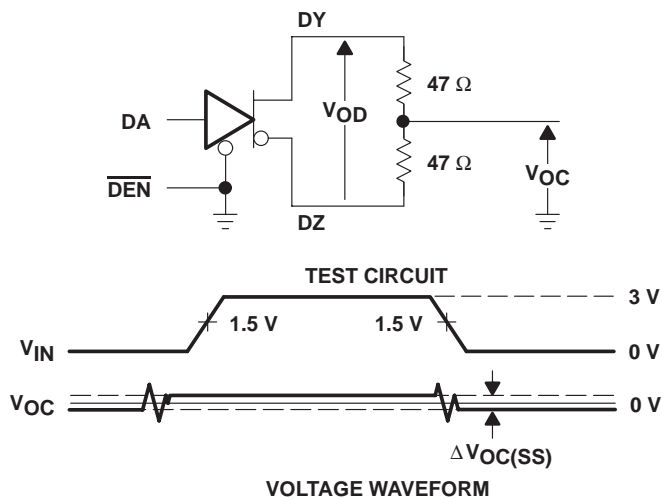
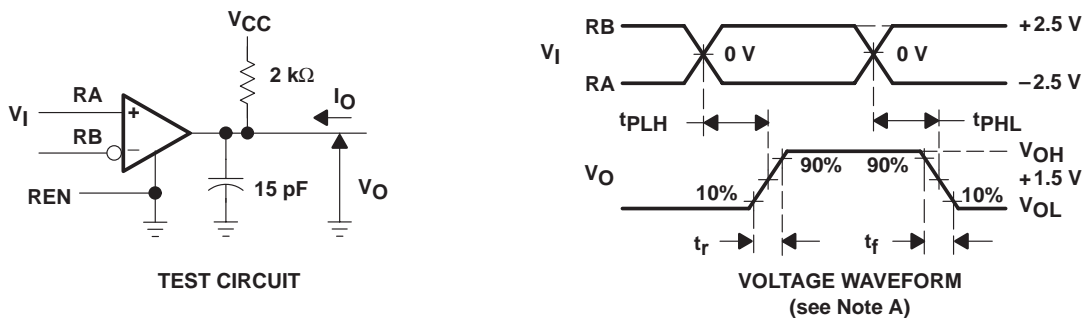


Figure 3. Differential Driver Common Mode Output Voltage Tests



NOTE A: The input waveform $t_r, t_f \leq 10$ ns

Figure 4. Receiver Propagation and Transition Times

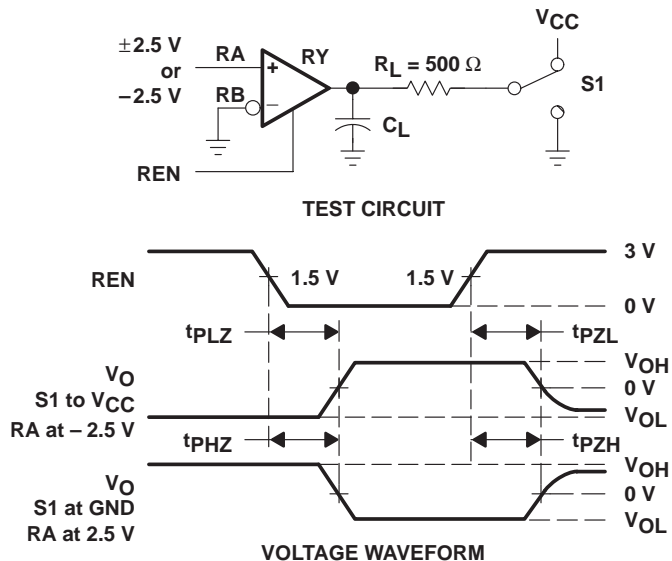


Figure 5. Receiver Enable and Disable Test Circuit and Waveform

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TYPICAL CHARACTERISTICS

MAXIMUM DRIVER DATA RATE VS CAPACITIVE LOAD

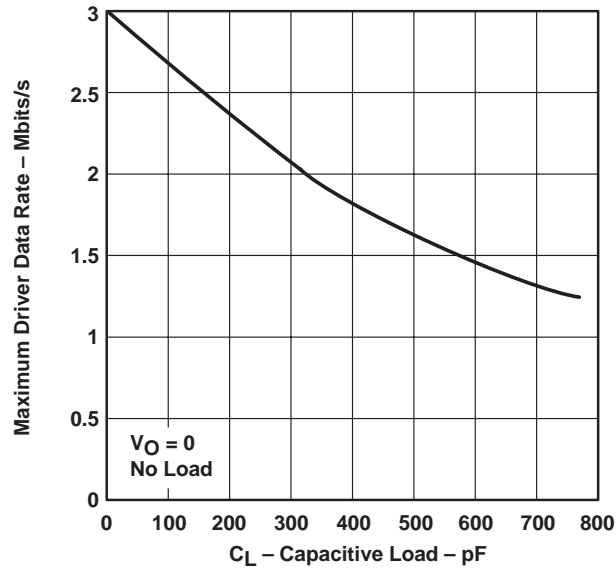


Figure 6



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APPLICATION INFORMATION

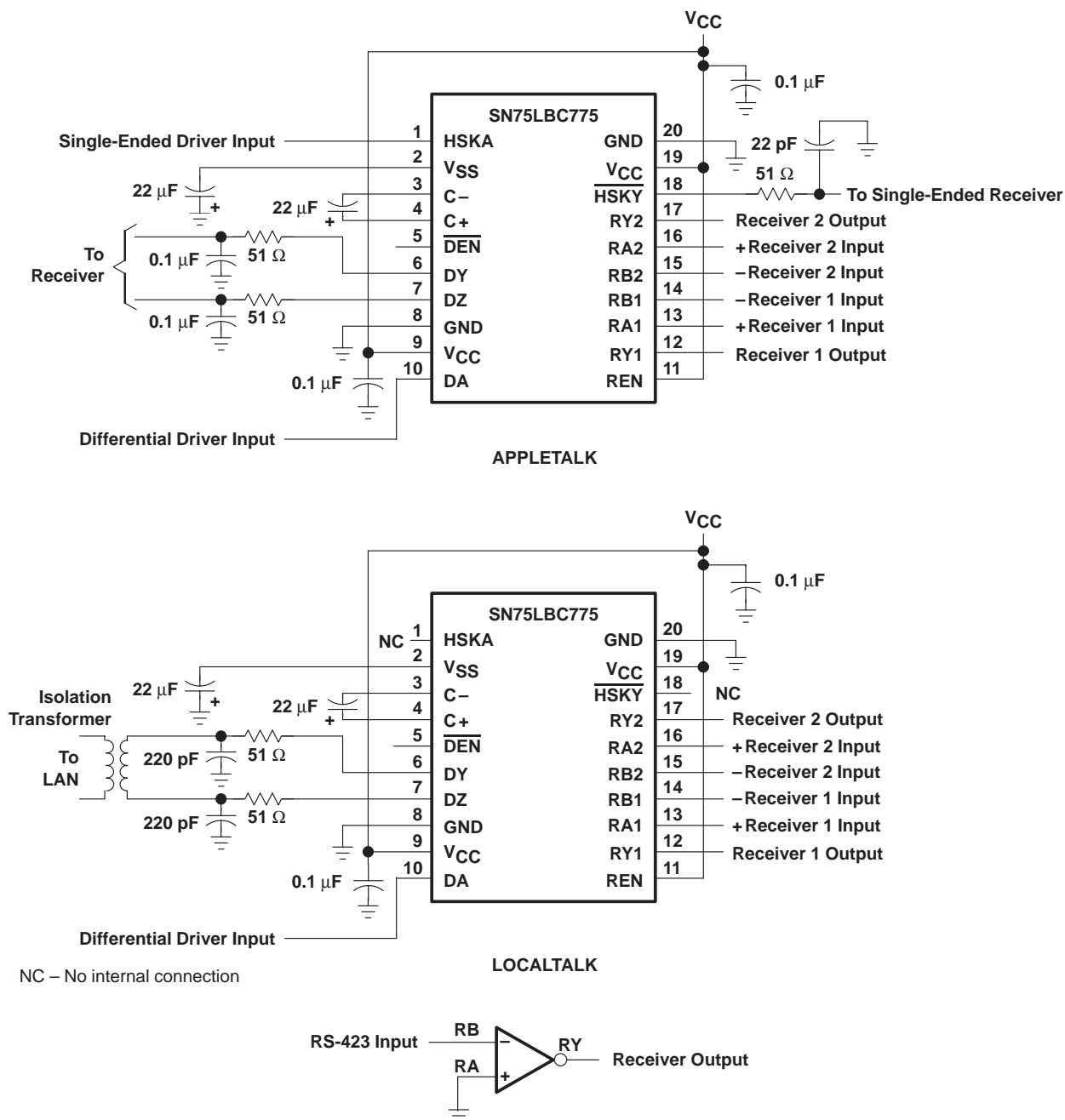


Figure 7. Receiving RS-423 Signals With a Differential Receiver

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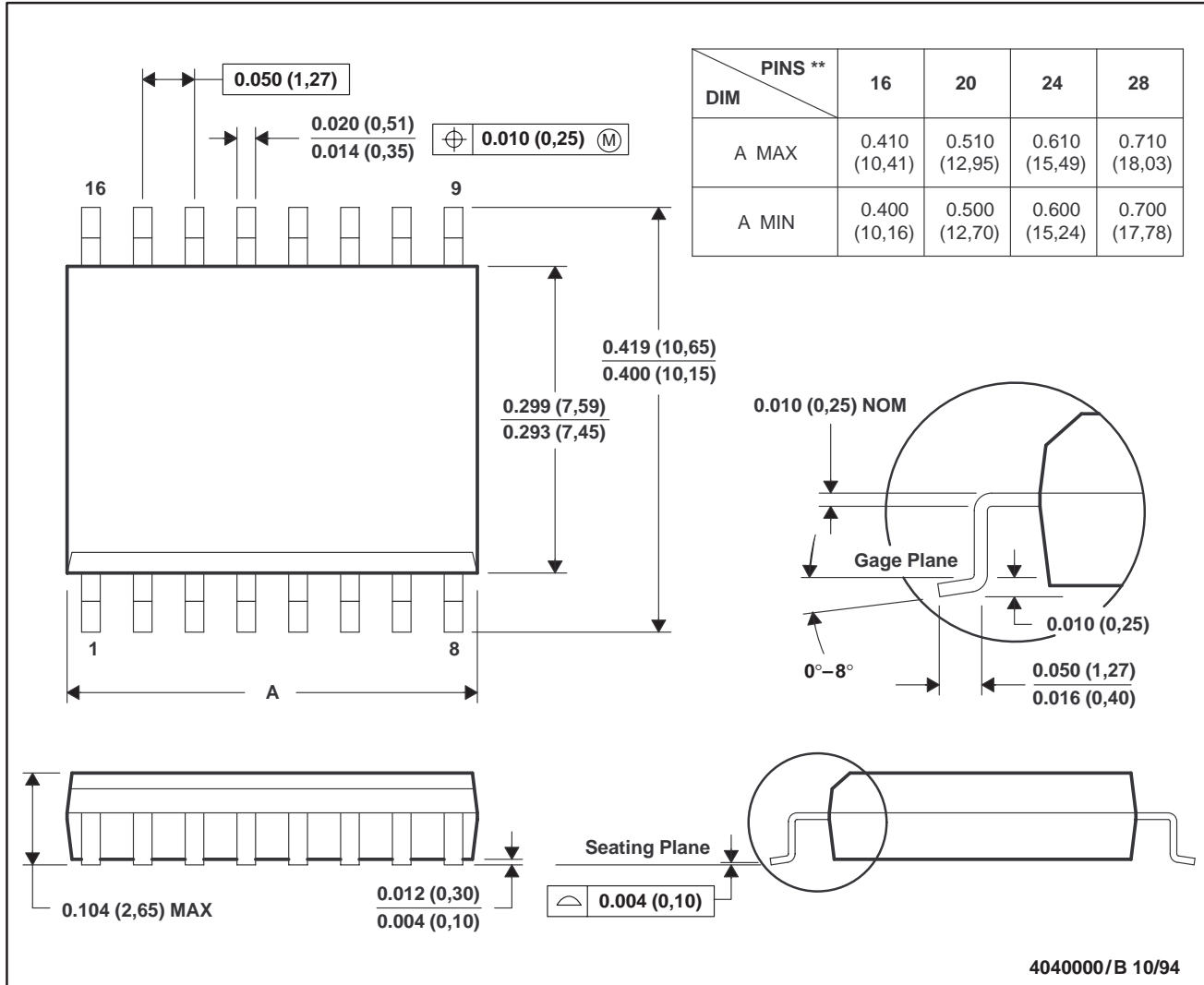
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MECHANICAL INFORMATION

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



- NOTES:
- B. All linear dimensions are in inches (millimeters).
 - C. This drawing is subject to change without notice.
 - D. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
 - E. Falls within JEDEC MS-013



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